## Application/Control No. Applicant(s)/Patent Under Reexamination 10/022,263 ONO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Daniel I Walsh 2876 **U.S. PATENT DOCUMENTS** Document Number Date Country Code-Number-Kind Code Classification MM-YYYY US-6,149,058 11-2000 Albaret, Thierry 235/380 US-5,850,077 В 12-1998 Tognazzini, Bruce 235/380 US-6,168,078 01-2001 С Yanagi et al. 235/380 US-5,945,652 D 08-1999 Ohki et al. 235/380 US-6,189,782 Ε 02-2001 Takami et al. 235/375 F US-G US-Н USı US-J US-US-Κ US-L М US-FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν EP0872816A2 10-1998 Japan Niwata et al. EP0820043A2 0 01-1998 Japan Takami et al. Ρ EP0820043A3 04-2003 Japan Takami et al. Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W Х

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.